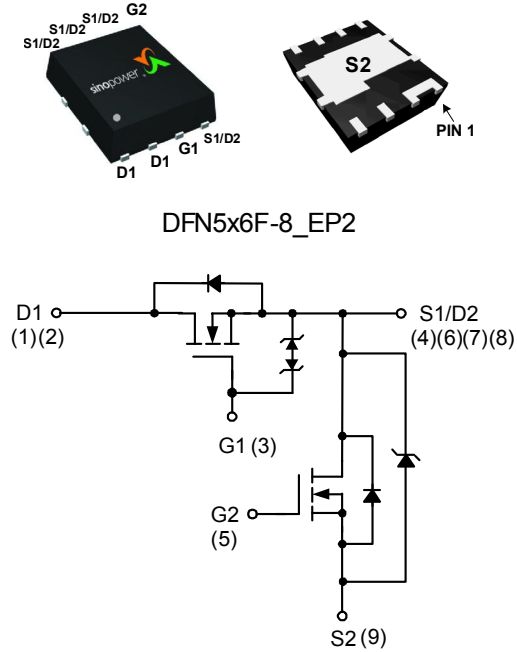


Dual N-Channel Enhancement Mode MOSFET

Features

- **Channel 1 (ESD Protection)**
30V/70A,
 $R_{DS(ON)} = 3m\Omega$ (max.) @ $V_{GS} = 10V$
 $R_{DS(ON)} = 5.2m\Omega$ (max.) @ $V_{GS} = 4.5V$
- **Channel 2 (Integrated Schottky diode)**
30V/100A,
 $R_{DS(ON)} = 1m\Omega$ (max.) @ $V_{GS} = 10V$
 $R_{DS(ON)} = 1.6m\Omega$ (max.) @ $V_{GS} = 4.5V$
- 100% UIS + R_g Tested
- Dual Dies Package and Minimize Board Space
- Lower Q_g and Q_{gd} for High-Speed Switching
- Lower $R_{DS(ON)}$ to Minimize Conduction Losses
- Reliable and Rugged
- Lead Free Available (RoHS Compliant)

Pin Description

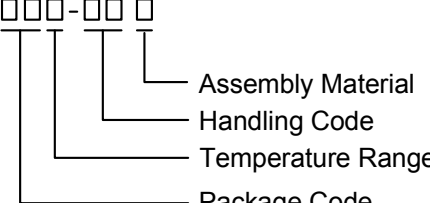



N-Channel MOSFET

Applications

- Power Management in Desktop Computer or DC/DC Converters.

Ordering and Marking Information

<p>SM7350FK □□□-□□ □</p>  <p>Assembly Material Handling Code Temperature Range Package Code</p>	<p>Package Code KP : DFN5x6F-8_EP2 Operating Junction Temperature Range C : -55 to 150 °C Handling Code TR : Tape & Reel Assembly Material G : Halogen and Lead Free Device</p>
<p>SM7350FK QG : </p>	<p>XXXXX - Lot Code</p>

Note : SINOPOWER lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. SINOPOWER lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. SINOPOWER defines “Green” to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

SINOPOWER reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Channel 1	Channel 2	Unit	
Common Ratings					
V_{DSS}	Drain-Source Voltage	30		V	
V_{GSS}	Gate-Source Voltage	± 20		V	
T_J	Maximum Junction Temperature	150		$^\circ\text{C}$	
T_{STG}	Storage Temperature Range	-55 to 150		$^\circ\text{C}$	
I_S	Diode Continuous Forward Current	22	64	A	
I_D	Continuous Drain Current	$T_C=25^\circ\text{C}$	70	100^a	A
		$T_C=100^\circ\text{C}$	44	100	
P_D	Maximum Power Dissipation	$T_C=25^\circ\text{C}$	25	125	W
		$T_C=100^\circ\text{C}$	10	50	
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	5	1	$^\circ\text{C/W}$
I_D	Continuous Drain Current	$T_A=25^\circ\text{C}$	14	24	A
		$T_A=70^\circ\text{C}$	11	22	
I_{DM}^b	Pulse Drain Current Tested	$T_A=25^\circ\text{C}$	56	96	A
P_D	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	1.13	1.66	W
		$T_A=70^\circ\text{C}$	0.72	1.06	
$R_{\theta JA}^c$	Thermal Resistance-Junction to Ambient	$t \leq 10\text{s}$	55	35	$^\circ\text{C/W}$
		Steady State	110	75	
I_{AS}^d	Avalanche Current, Single pulse	$L=0.1\text{mH}$	28	67	A
E_{AS}^d	Avalanche Energy, Single pulse	$L=0.1\text{mH}$	39.2	224.45	mJ

Note a : Max. continuous current is limited by bonding wire.

Note b : Pulse width is limited by max. junction temperature.

Note c : Surface mounted on 1in^2 pad area, steady state $t=999\text{s}$.

Note d : UIS tested and pulse width are limited by maximum junction temperature 150°C (initial temperature $T_J=25^\circ\text{C}$).

Channel 1 Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Channel 1			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	30	-	-	V
BV _{DSSst}	Drain-Source Breakdown Voltage (transient)	V _{GS} =0V, I _{D(aval)} =30A T _{case} =25°C, t _{transient} =100ns	34	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V	-	-	1	μA
		T _J =85°C	-	-	30	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	1.3	1.7	2.5	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±10	μA
R _{DS(ON)} ^e	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =13A	-	2.5	3	mΩ
		T _J =125°C	-	3.6	-	
		V _{GS} =4.5V, I _{DS} =11A	-	4	5.2	
G _{fs}	Forward Transconductance	V _{DS} =5V, I _{DS} =11A	-	25	-	S
Diode Characteristics						
V _{SD} ^e	Diode Forward Voltage	I _{SD} =13A, V _{GS} =0V	-	0.8	1.1	V
t _{rr}	Reverse Recovery Time	I _{DS} =13A, dI _{SD} /dt=100A/μs V _{DD} =15V	-	34.9	-	ns
t _a	Charge Time		-	17.6	-	
t _b	Discharge Time		-	17.3	-	
Q _{rr}	Reverse Recovery Charge		-	25.6	-	
Dynamic Characteristics^f						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	-	1	2	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, Frequency=1.0MHz	-	1420	1846	pF
C _{oss}	Output Capacitance		-	900	-	
C _{rss}	Reverse Transfer Capacitance		-	71	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =15V, R _L =15Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω	-	14	-	ns
t _r	Turn-on Rise Time		-	11	-	
t _{d(OFF)}	Turn-off Delay Time		-	32	-	
t _f	Turn-off Fall Time		-	36	-	
Gate Charge Characteristics^f						
Q _g	Total Gate Charge	V _{DS} =15V, V _{GS} =4.5V, I _{DS} =13A	-	12.4	-	nC
Q _g	Total Gate Charge	V _{DS} =15V, V _{GS} =10V, I _{DS} =13A	-	25	-	
Q _{gth}	Threshold Gate Charge		-	2.2	-	
Q _{gs}	Gate-Source Charge		-	3.4	-	
Q _{gd}	Gate-Drain Charge		-	4.6	-	

Note d : Pulse test ; pulse width ≤ 300μs, duty cycle ≤ 2%.

Note e : Guaranteed by design, not subject to production testing.

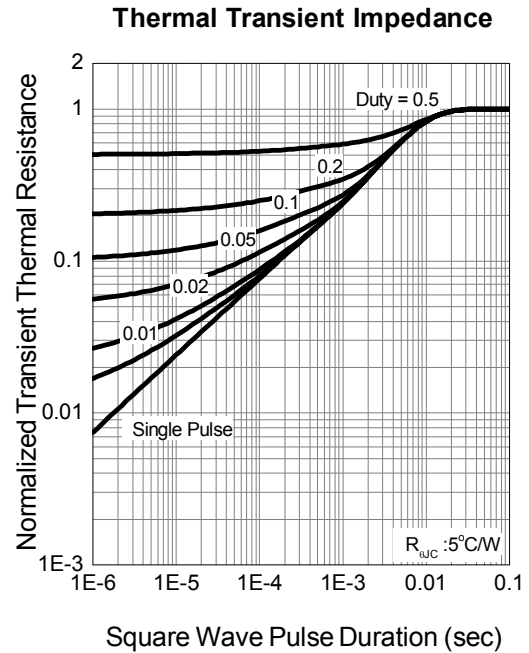
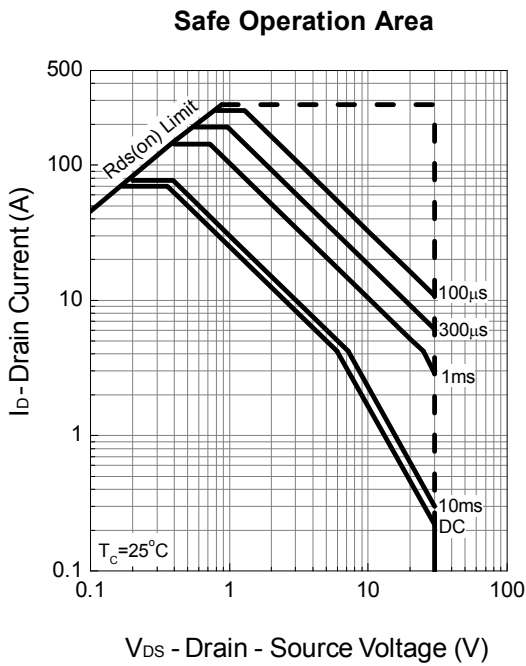
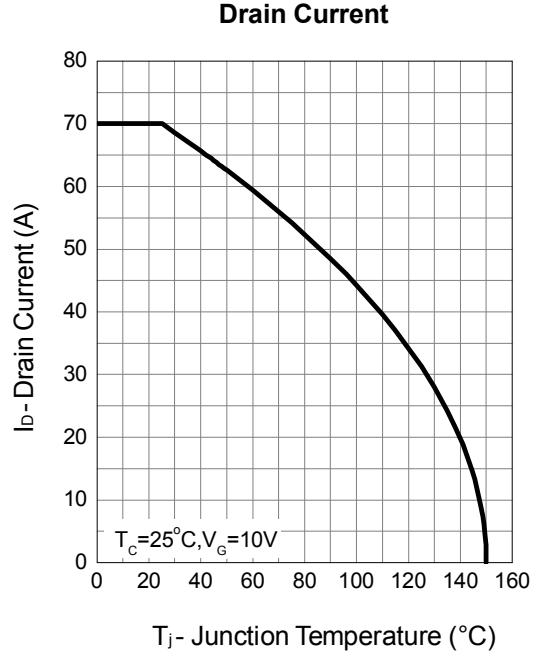
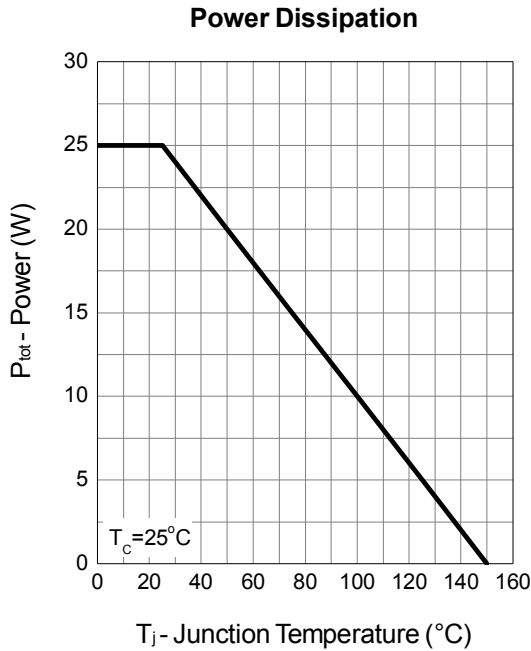
Channel 2 Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Channel 2			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	30	-	-	V
BV _{DSS(t)}	Drain-Source Breakdown Voltage (transient)	V _{GS} =0V, I _{D(aval)} =50A T _{case} =25°C, t _{transient} =100ns	34	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V	-	-	500	μA
		T _J =85°C	-	-	5	mA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	1.3	1.7	2.5	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^e	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =25A	-	0.7	1	mΩ
		T _J =125°C	-	1.06	-	
		V _{GS} =4.5V, I _{DS} =20A	-	1	1.6	
G _{fs}	Forward Transconductance	V _{DS} =5V, I _{DS} =20A	-	42	-	S
Diode Characteristics						
V _{SD} ^e	Diode Forward Voltage	I _{SD} =2A, V _{GS} =0V	-	0.55	0.7	V
		I _{SD} =25A, V _{GS} =0V	-	0.75	1.1	
t _{rr}	Reverse Recovery Time	I _{DS} =25A, di _{SD} /dt=100A/μs V _{DD} =15V	-	65	-	ns
t _a	Charge Time		-	35	-	
t _b	Discharge Time		-	30	-	
Q _{rr}	Reverse Recovery Charge		-	69	-	
Dynamic Characteristics^f						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	-	0.5	1	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, Frequency=1.0MHz	-	5500	7150	pF
C _{oss}	Output Capacitance		-	2390	-	
C _{rss}	Reverse Transfer Capacitance		-	180	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =15V, R _L =15Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω	-	25	-	ns
t _r	Turn-on Rise Time		-	12	-	
t _{d(OFF)}	Turn-off Delay Time		-	85	-	
t _f	Turn-off Fall Time		-	98	-	
Gate Charge Characteristics^f						
Q _g	Total Gate Charge	V _{DS} =15V, V _{GS} =4.5V, I _{DS} =25A	-	34.4	-	nC
Q _g	Total Gate Charge	V _{DS} =15V, V _{GS} =10V, I _{DS} =25A	-	76.6	-	
Q _{g(th)}	Threshold Gate Charge		-	9.2	-	
Q _{gs}	Gate-Source Charge		-	14.3	-	
Q _{gd}	Gate-Drain Charge	-	6	-		

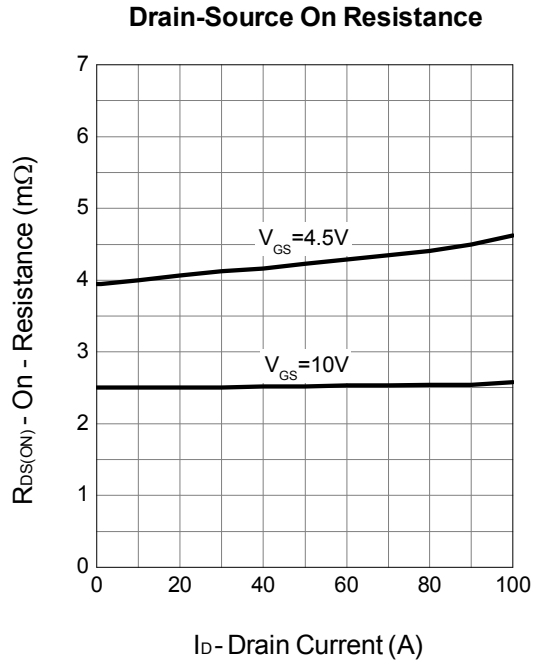
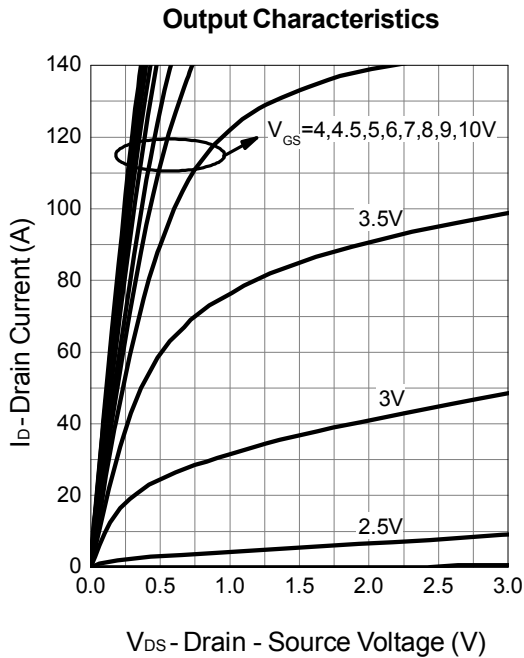
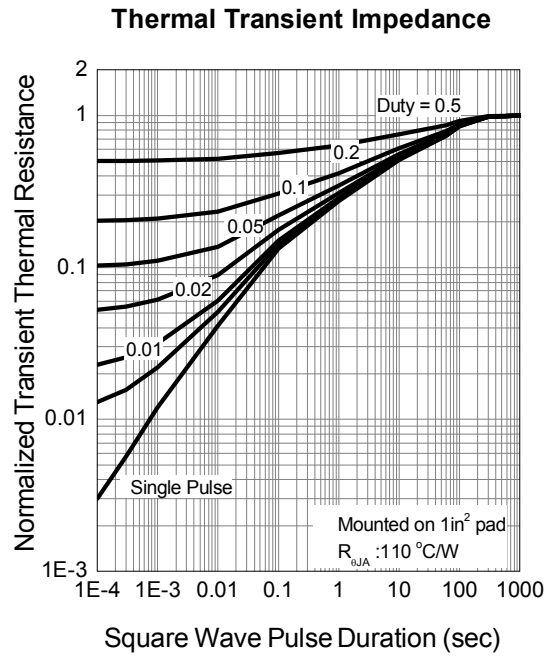
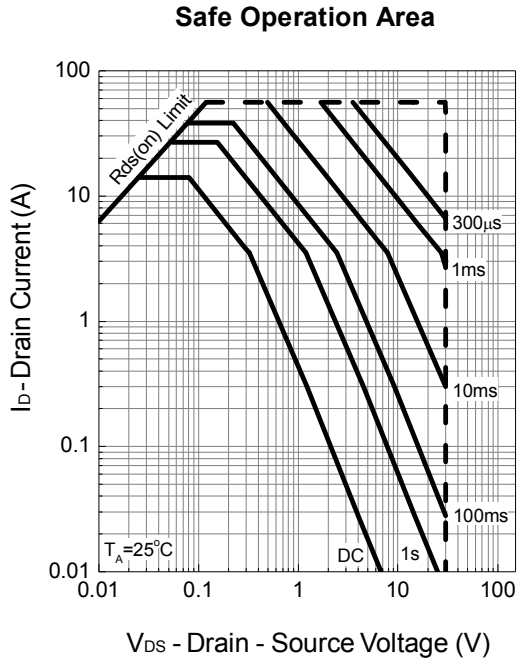
Note e : Pulse test ; pulse width≤300μs, duty cycle≤2%.

Note f : Guaranteed by design, not subject to production testing.

Channel 1 Typical Operating Characteristics

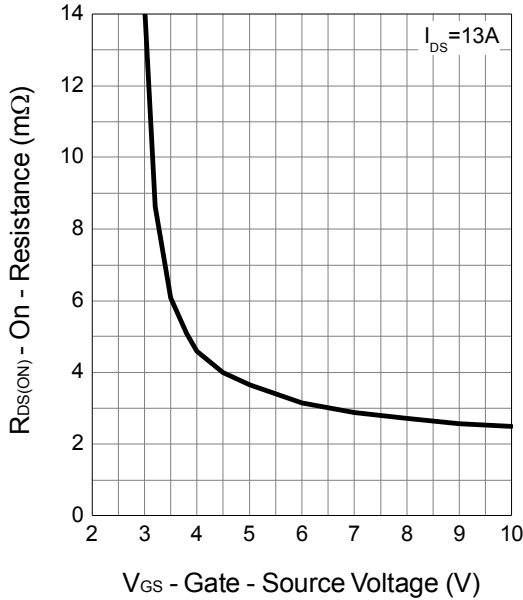


Channel 1 Typical Operating Characteristics (Cont.)

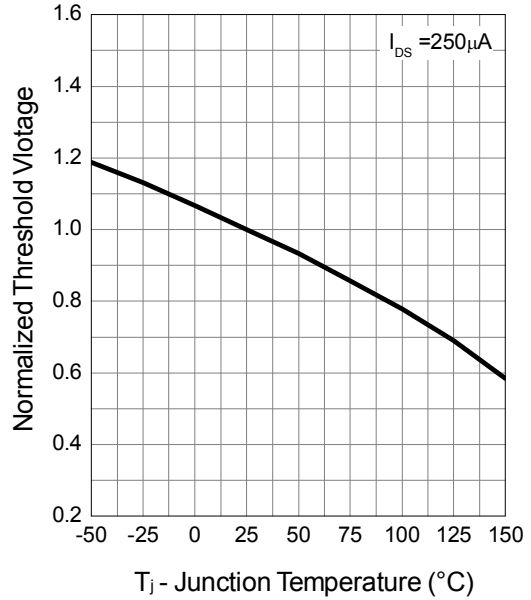


Channel 1 Typical Operating Characteristics (Cont.)

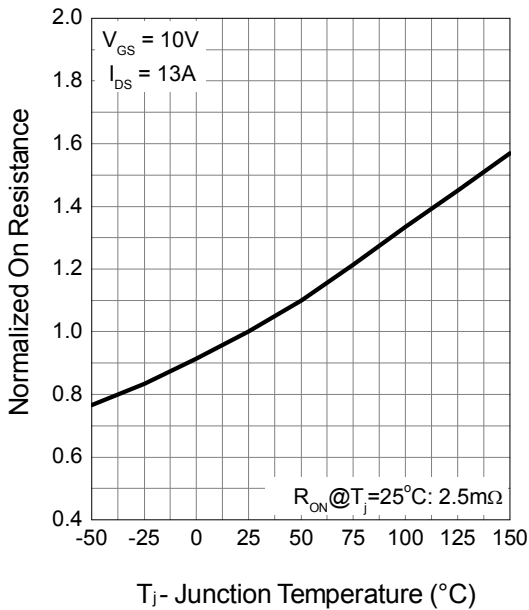
Gate-Source On Resistance



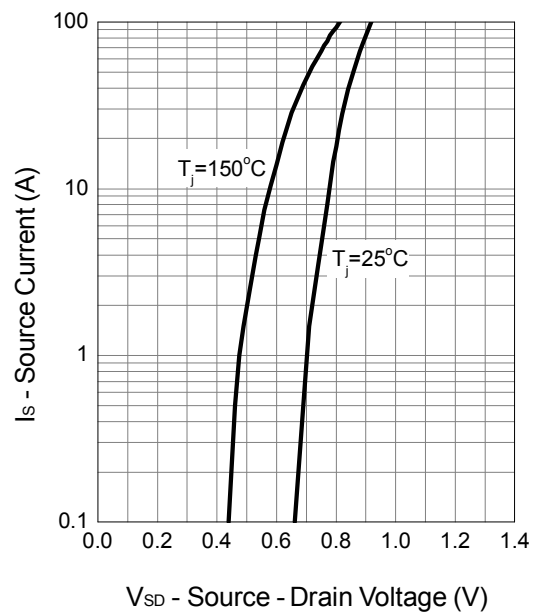
Gate Threshold Voltage



Drain-Source On Resistance

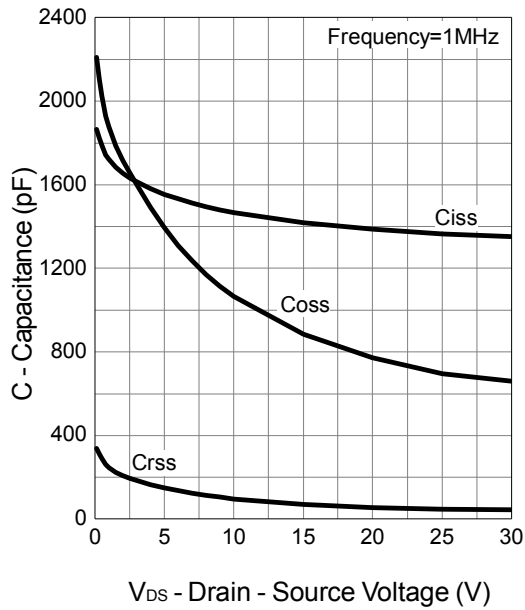


Source-Drain Diode Forward

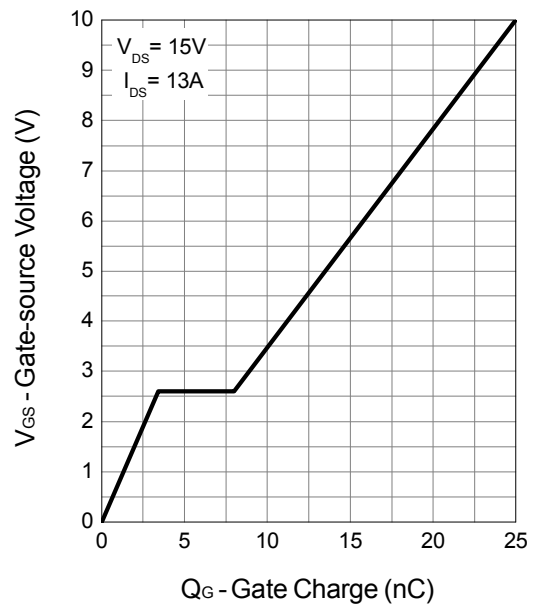


Channel 1 Typical Operating Characteristics (Cont.)

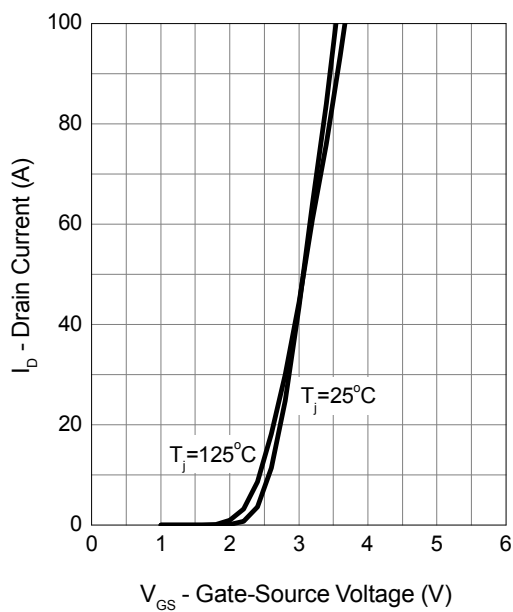
Capacitance



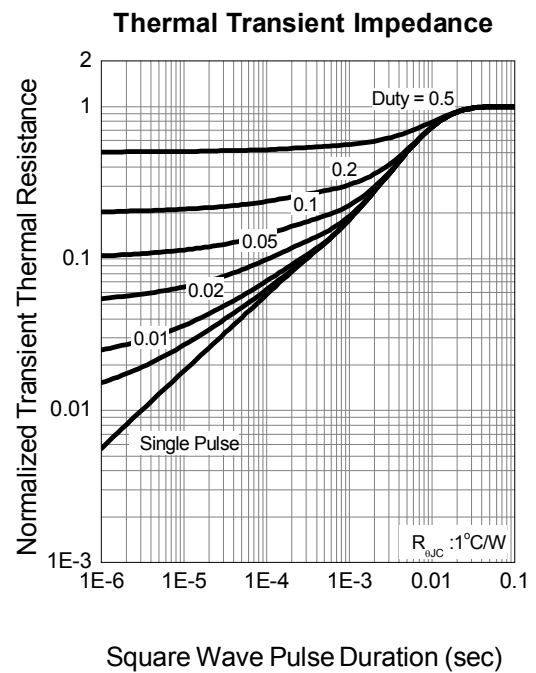
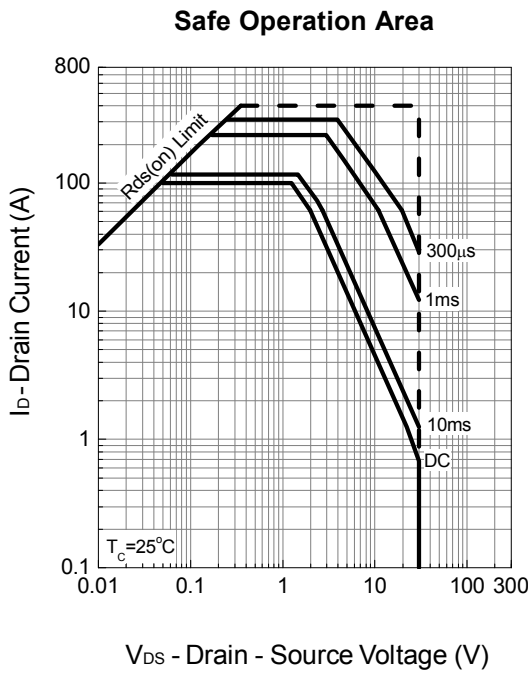
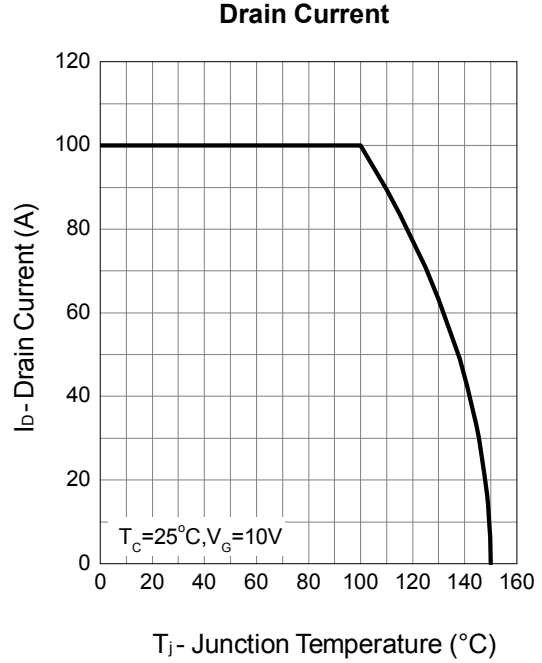
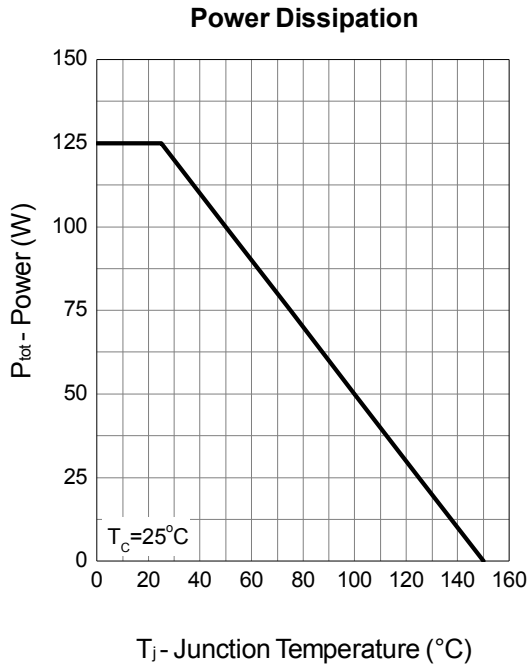
Gate Charge



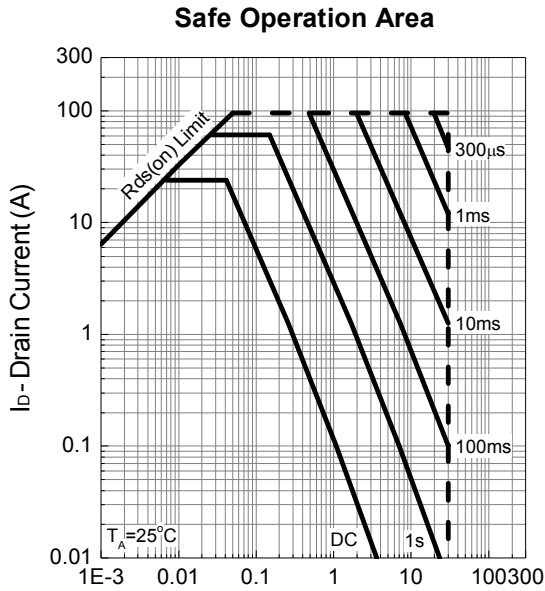
Transfer Characteristics



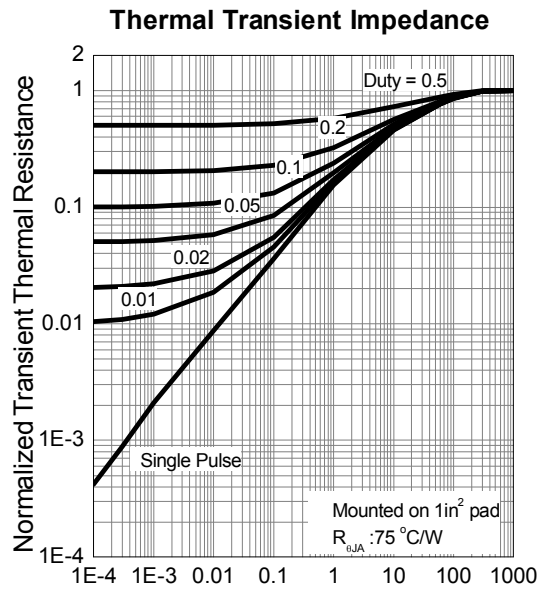
Channel 2 Typical Operating Characteristics



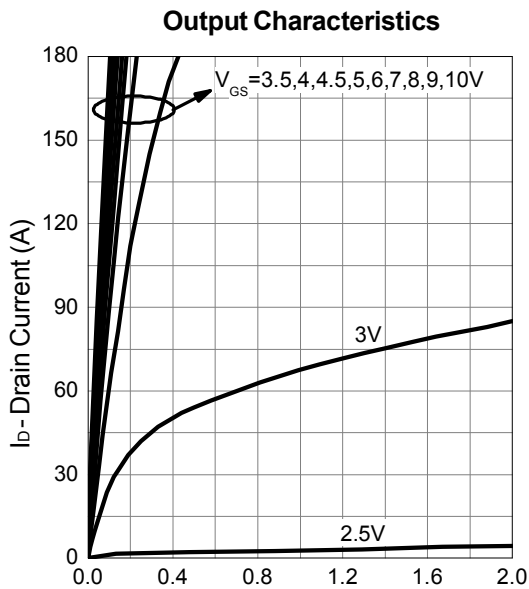
Channel 2 Typical Operating Characteristics (Cont.)



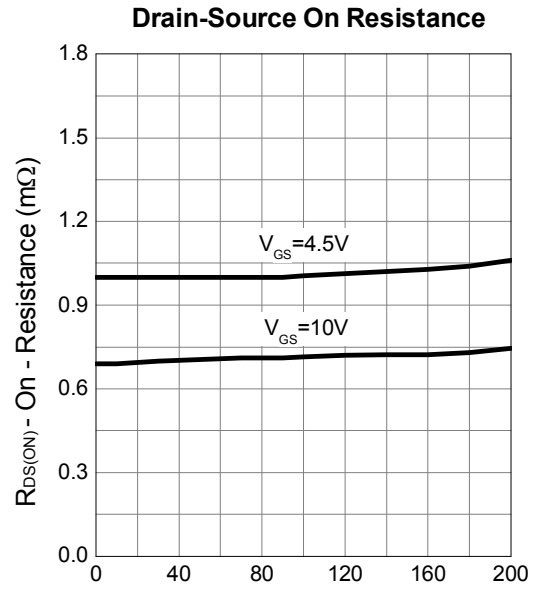
V_{DS} -Drain-Source Voltage (V)



Square Wave Pulse Duration (sec)



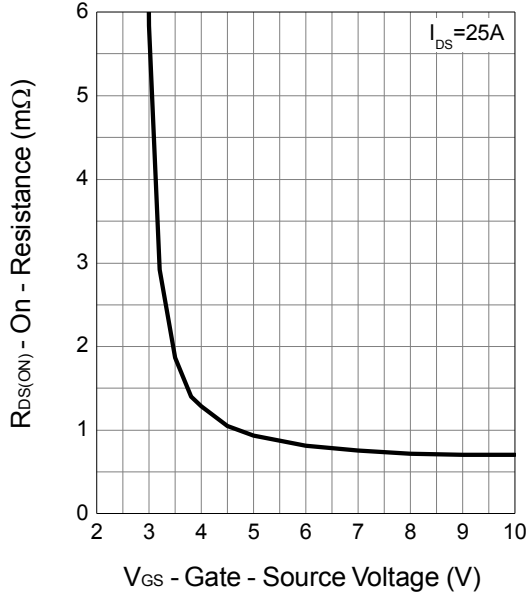
V_{DS} -Drain-Source Voltage (V)



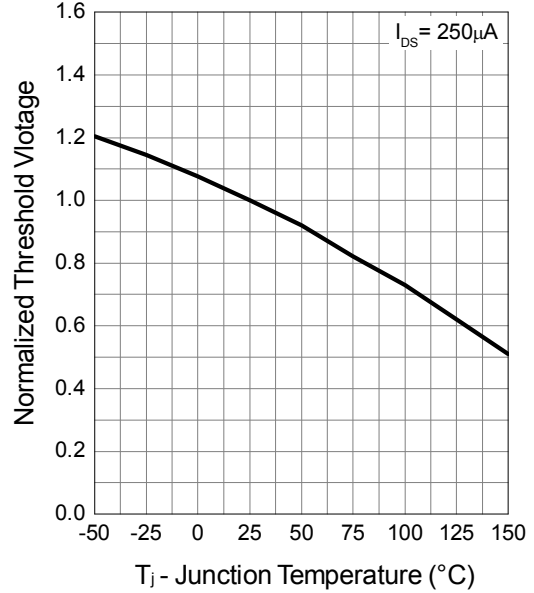
I_D -Drain Current (A)

Channel 2 Typical Operating Characteristics (Cont.)

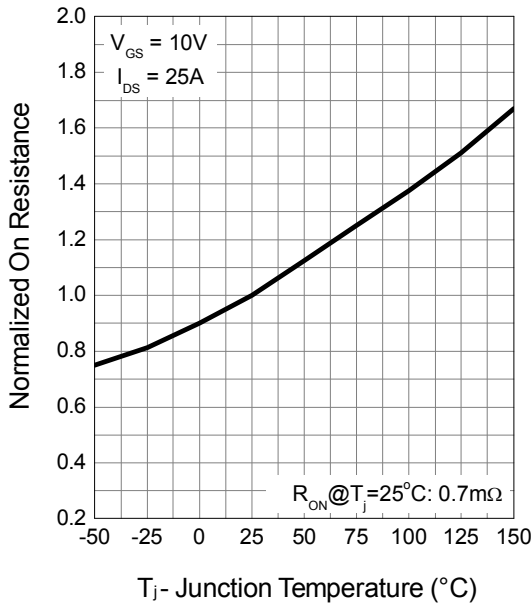
Gate-Source On Resistance



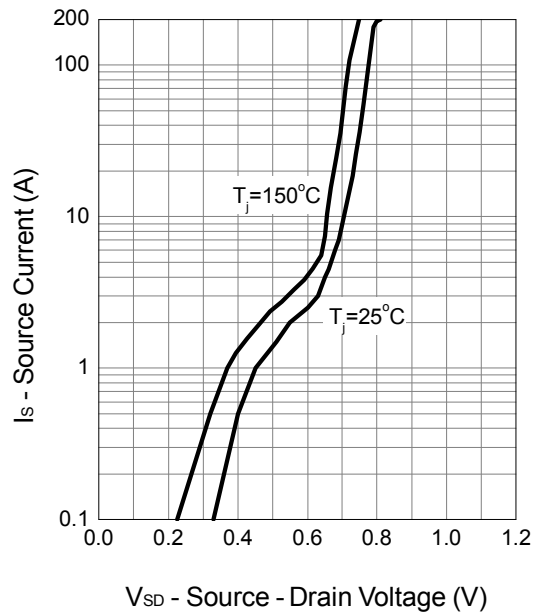
Gate Threshold Voltage



Drain-Source On Resistance

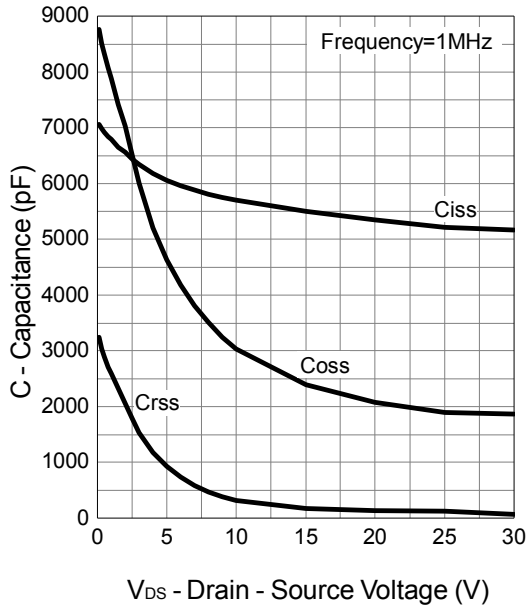


Source-Drain Diode Forward

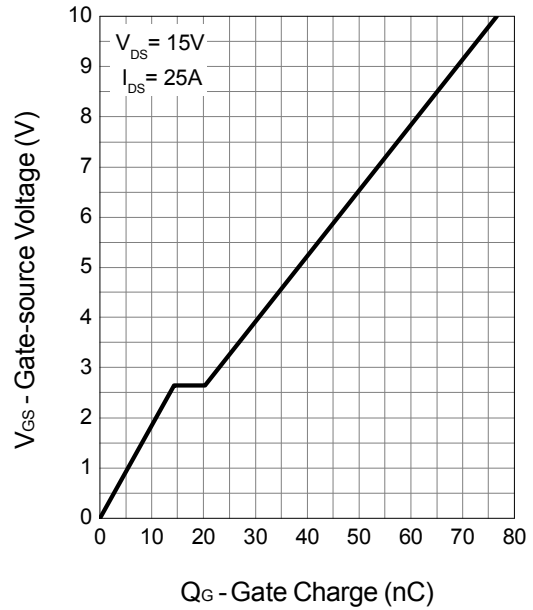


Channel 2 Typical Operating Characteristics (Cont.)

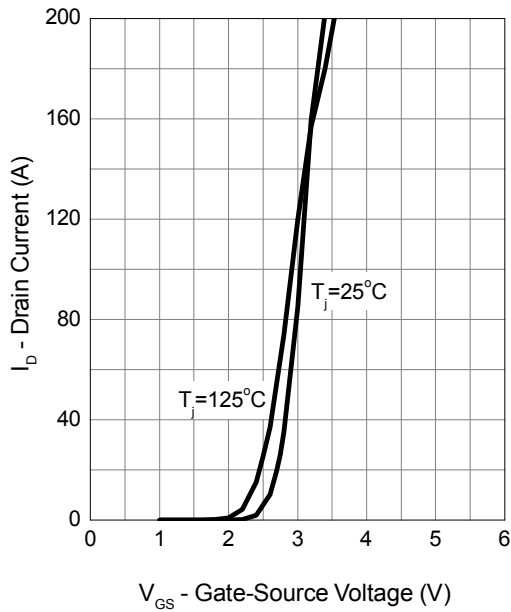
Capacitance



Gate Charge

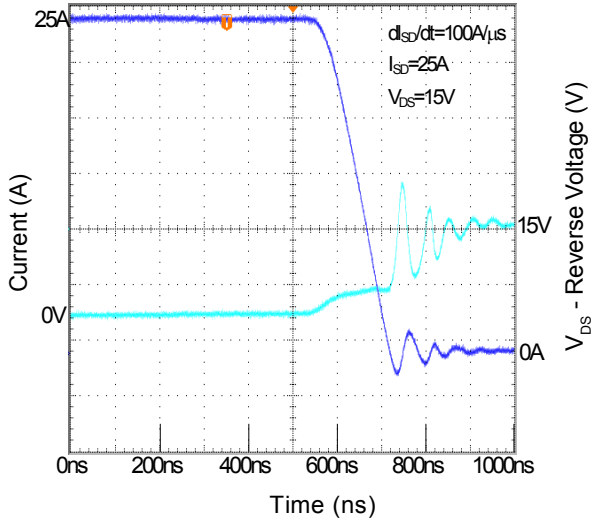


Transfer Characteristics

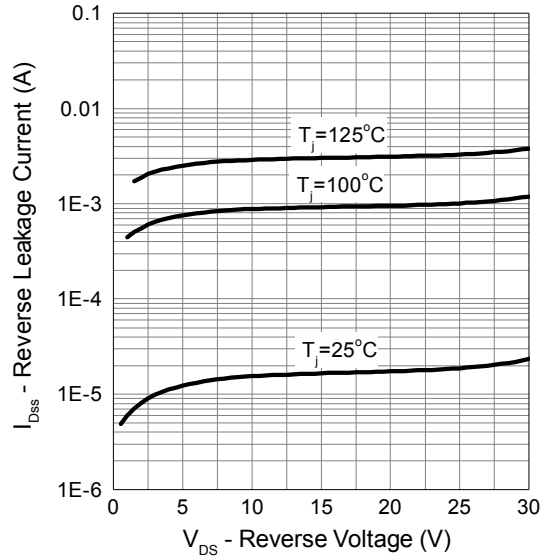


Channel 2 Schottky Body Diode Characteristics

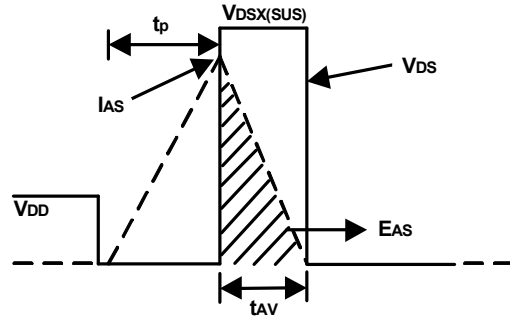
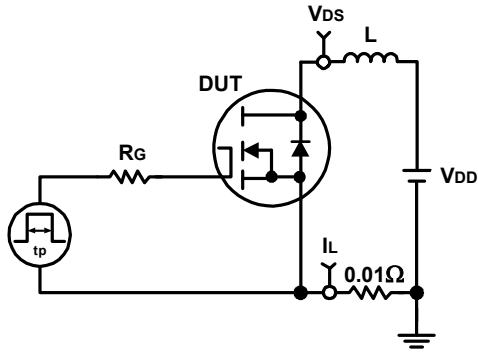
Body Diode Reverse Recovery Diode Characteristics



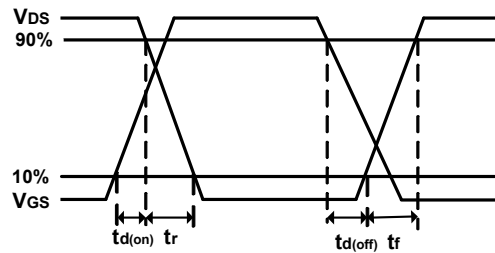
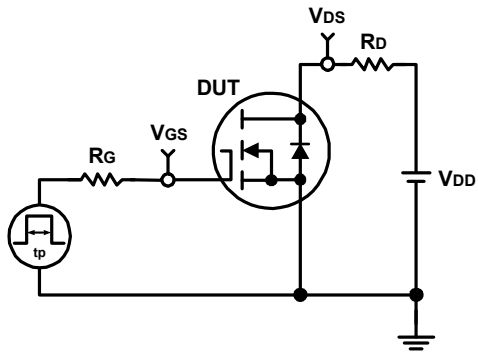
Body Diode Reverse Leakage Current



Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms



Disclaimer

Sinopower Semiconductor, Inc. (hereinafter “Sinopower”) has been making great efforts to development high quality and better performance products to satisfy all customers’ needs. However, a product may fail to meet customer’s expectation or malfunction for various situations.

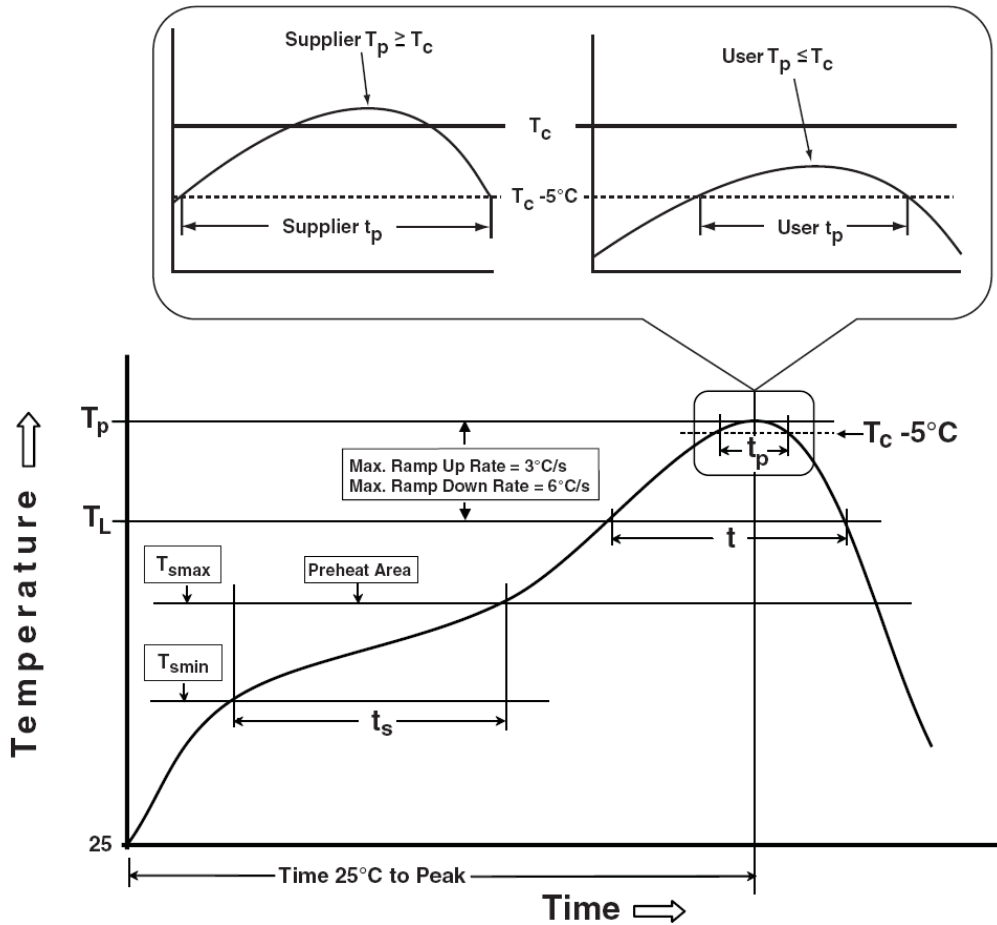
All information which is shown in the datasheet is based on Sinopower’s research and development result, therefore, Sinopower shall reserve the right to adjust the content and monitor the production.

In order to unify the quality and performance, Sinopower has been following JEDEC while defines assembly rule. Notwithstanding all the suppliers basically follow the rule for each product, different processes may cause slightly different results.

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Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak		
Temperature min (T_{smin})	100 °C	150 °C
Temperature max (T_{smax})	150 °C	200 °C
Time (T_{smin} to T_{smax}) (t_s)	60-120 seconds	60-120 seconds
Average ramp-up rate (T_{smax} to T_p)	3 °C/second max.	3°C/second max.
Liquidous temperature (T_L)	183 °C	217 °C
Time at liquidous (t_L)	60-150 seconds	60-150 seconds
Peak package body Temperature (T_p)*	See Classification Temp in table 1	See Classification Temp in table 2
Time (t_p)** within 5°C of the specified classification temperature (T_c)	20** seconds	30** seconds
Average ramp-down rate (T_p to T_{smax})	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
* Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum.		
** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.		

Table 1. SnPb Eutectic Process – Classification Temperatures (T_c)

Package Thickness	Volume mm ³ <350	Volume mm ³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (T_c)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	1000 Hrs, 80% of VDS max @ T_{jmax}
HTGB	JESD-22, A108	1000 Hrs, 100% of VGS max @ T_{jmax}
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C

Customer Service

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TEL: 886-3-5635818 Fax: 886-3-5635080